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Conduction channels of an InAs-Al nanowire Josephson weak link

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Abstract

We present a quantitative characterization of an electrically tunable Josephson junction defined in an InAs nanowire proximitized by an epitaxially-grown superconducting Al shell. The gate-dependence of the number of conduction channels and of the set of transmission coefficients are extracted from the highly nonlinear current–voltage characteristics. Although the transmissions evolve non-monotonically, the number of independent channels can be tuned, and configurations with a single quasi-ballistic channel achieved.

Superconductor–semiconductor–superconductor weak links are interesting hybrid structures in which the Josephson coupling energy, and therefore the supercurrent, can be modulated by an electric field\([1, 2]\). It is even possible to lower the carrier density enough in the weak link to achieve the conceptually simple situation of a quantum point contact (QPC), in which only a small number of conduction channels contribute to transport. Although these kind of hybrid microstructures have been explored for many years\([3]\), inducing strong superconducting correlations into the semiconductor in a reliable way has been achieved only recently. A well-defined (‘hard’) superconducting gap has been clearly demonstrated both in InAs nanowires\([3]\) and in In-GaAs/InAs two-dimensional electron gases\([5]\) by using\(\textit{in situ}\) epitaxially grown Al contacts. Many experiments\([6–10]\) are presently using these hybrid structures because they are promising candidates to implement topological superconductivity and Majorana bound states\([11, 12]\). A good understanding of their basic microscopic transport features is therefore necessary. Here we track the evolution of the conduction channels of a QPC based on an InAs-Al (core–shell) nanowire\([13]\), as gate voltages gradually deplete the weak link region.

Nanowires were dispersed onto a Si substrate covered with 500 nm of silicon oxide. After an Ar ion milling step (energy 500 eV, 90 s, nominal Al\(_2\)O\(_3\) etch rate \(\sim 4\) nm min\(^{-1}\)), the Al shell was contacted by e-beam-evaporated 100 nm-thick micrometer-scale Al leads. The QPC was then defined by completely removing the Al shell over 150 nm by a selective wet etching step in Transene D. The etching region was defined by e-beam lithography using a PMMA (poly(methyl methacrylate)) layer deposited on a few-nm-thick optical resist that turns the Al-resist interface hydrophobic, hence preventing the peeling of the whole wire while etching\([14]\). In a subsequent lithography step, Au gates were fabricated on both sides of the exposed InAs core to allow tuning of the local carrier density. A micrograph of the device and the schematics of the measurement setup is depicted in figure 1. Symmetric biasing of the junction was achieved with a bridge of four resistances placed on the printed circuit board to which the sample is wire-bonded. The voltage \(V\) across the wire is measured with another pair of leads connected to the bias pads, whereas the current \(I\) is deduced from the voltage drop across resistance \(R\). Two independent voltage sources \(V_{G1}\) and \(V_{G2}\) connected to the side-gates control the depletion of the QPC.

Measurements were carried out in a He\(_3\) refrigerator at a base temperature of 250 mK. Figure 2(a) shows \(I–V\) characteristics taken in the superconducting state at various values of the gate voltages, in the common mode \(V_{G1} = V_{G2} = V_{G}\). The overall current decreases as \(V_{G}\) is lowered. This correlates with the reduction of the differential conductance \(dI/dV\) in the normal state, as shown in figure 2(b) with data at the same values of \(V_{G}\) taken above the superconducting transition temperature of Al. This figure also shows that \(dI/dV\) varies with \(V\).
evolution with $V_g$ of the zero voltage conductance in the normal state is shown in figure 2(c). The absence of conductance plateaus merely indicates that the channels do not close one after the other as $V_g$ decreases, in contrast to what happens with clean QPCs in two-dimensional electron gases. A detailed and comprehensive account of the evolution of all transmissions can however be obtained from the superconducting state data. The $I–V$ characteristics in the superconducting state display kinks at voltages close to $\frac{D}{e^2}$ where $n$ is an integer number ($n = 1, 2, 3$ are clearly visible), $e$ is the electron’s charge, and $\Delta \approx 160 \mu eV$ the superconducting gap in the proximitized InAs. These non-linearities result from the charge transport occurring through multiple Andreev reflections (MAR) [15]. As shown by experiments on atomic contacts [16], the number of channels $N$ and the set of transmissions coefficients $\{\tau_1, \ldots, \tau_N\}$ can be determined by decomposing the $I–V$ characteristics into the contributions of a few channels using the well-established theory for MAR [17–19], with the gap and the
transmissions as adjustable parameters. Note however that the physics is a bit richer here because, as shown in figure 2(b), \( \frac{dI}{dV} \) varies with \( V \) and \( \frac{dI}{dV} \) \( (V) \approx \frac{dI}{dV} \) \(-V\). Although the MAR theory should then in principle be modified to include the energy dependence of the transmissions, here we simply treat separately the \( V > 0 \) and \( V < 0 \) halves of the I–Vs and get for each gate voltage value two estimations of the set of transmissions\(^4\).

The fits, the corresponding channels’ transmissions and their sum are shown in figures 3(a), (c) and (d), respectively. The three panels in figures 3(c) and (d) correspond to data taken along the three gating paths shown in figure 3(b). The left panel of figure 3(a) shows the fits (lines) of the \( V > 0 \) data of figure 2(a) (open symbols), which are taken at gate voltages marked with arrows of the same color on the leftmost panel of figure 3(c). The right panel of figure 3(a) shows similar data taken at \( V_{G1} = -5.5 \) V, for five values of \( V_{G2} \) marked with arrows on the rightmost panel of figure 3(c).

According to the maximum measured normal-state conductance \( \frac{dI}{dV} \approx 2.5 \) \( G_{IV} \), one expects at least three independent conducting channels. Fits are performed using a Monte-Carlo algorithm described elsewhere [20]. They require at most four channels in the whole gate voltage range investigated. The mean value obtained for the superconducting gap is \( \Delta = 160 \mu eV \) with a standard deviation of \( 7 \mu eV \). The gap appears to be almost gate-voltage-independent, as expected from the fact that the Al shell completely covers the InAs regions that act as superconducting banks for the QPC.

Good fits with the MAR theory are obtained everywhere except near pinchoff \((V_{G1} \text{ and } V_{G2} \text{ both below } -3.5V)\), where the relative variations of \( dI/dV \) in the normal state become large. Furthermore, in this region, the current is only carried by channels with low transmission, for which the short junction limit is no longer valid; as argued in [21], additional resonances develop in the I–V when the channel is longer than \( \xi_0 \sqrt{T} \), where \( \xi_0 \) is the superconducting coherence length in the proximitized InAs.

The evolution of the transmissions as obtained from the \( V < 0 \) (full circles) and \( V > 0 \) (open squares) halves of the I–Vs is shown in figure 3(c). High transmissions are determined to a good accuracy \((\pm 0.03)\), whereas there is some uncertainty on lower transmissions, in particular when four channels contribute to the current. Despite the fact that the differential conductance in the normal state depends on \( V \), both determinations give very similar results. Moreover, the extracted total conductance \( G_{tot} = G_0(\tau_1 + \tau_2 + \tau_3 + \tau_4) \) remains mostly within the measured range of variation of the differential conductance in the normal state (see the leftmost panel in figure 3(d)).

When lowering the gate voltages, the number of channels decreases from four to one, although individual transmissions change non-monotonously. This behaviour is probably a consequence of impurity charges (unintentional background doping, deep charge traps in the underneath dielectric, etc.) near the InAs region giving rise to random fluctuations of the confinement potential in addition to the one defined by the split gates, as often observed in semiconducting QPCs. Note that even in the absence of disorder, a Fermi velocity mismatch between the protected and unprotected regions of the nanowire could also give rise to standing waves, leading to resonances and non-monotonicity of transmission with gate voltage. When only a single gate voltage is decreased (gating path B), conducting channels evolve more gradually than when both are, as expected. Interestingly, at \( V_{G1} = -5.5 \) V, \( V_{G2} = 0 \), the current flows through a single quasi-ballistic channel \((\tau_1 = 0.98)\) (black curve in the right panel of figure 3(a)). One also observes that the I–Vs change dramatically along gating path C (right panel of figure 3(a)), even though the total conductance (right panel of figure 3(d)) remains almost constant. This reveals the smooth decrease of the transmission of one channel compensating almost exactly the increase of the second one (see right panel of figure 3(c)). Similar transfer of weights is observed at several places in figure 3(c).

In summary, we have shown that it is possible to track the conduction channels’ transmissions of an InAs nanowire superconducting QPC by measuring its current–voltage characteristics. Agreement with the MAR theory in the short-junction limit is satisfactory except very close to pinchoff. This gives confidence that following the evolution of the MAR structure with magnetic field could be a promising method to probe the topological transition predicted for such InAs nanowires [22, 23]. The information obtained on the transmissions and on the superconducting gap from the I–Vs in the superconducting state can be used to better understand spectroscopy data of the Andreev bound states (ABS) that form when phase-biasing a QPC. Finally, we find situations where transport occurs through a single channel of transmission as high as 0.98, leading to ABS energies of the order of 10 GHz, which is favorable to probe ABS using circuit-QED techniques [24].

\(^4\) The total current through a single channel QPC with an arbitrary energy barrier is \( I(V) = \frac{e}{\tau} \int_{-\sqrt{\pi}}^{\sqrt{\pi}} dE \ \tau(V, V_g, E) \). The analysis performed here amounts to neglecting the \( V \) and \( E \) dependences of the transmission.
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Figure 3. (a) Measured $I–V$ characteristics (symbols) and best fits (lines) considering four independent channels. The curves are taken at gate voltages shown with corresponding color arrows in the leftmost and rightmost panels of (c), following gate paths A and C described in (b): path A: sweep $V_{g1} = V_{g2} = V_g$; path B: sweep $V_{g1}$ while $V_{g2} = 0$; path C: sweep $V_{g2}$ while $V_{g1} = -5.5 V$. (c), (d) Individual channel transmissions and total transmission $G_{tot}$ obtained from the fits as a function of gate voltages. Note the inverted gate-voltage scale on the central panel that ensures continuity between the three plots. Open symbols correspond to $V > 0$ fits and full symbols to $V < 0$ fits. In the leftmost panel of (d), the light green region indicates measured span of normal-state differential conductance $\partial I/\partial V$ for the $V$-range over which the fits are performed ($|V| < 640 \mu V$).
References


